

**Search Notes**

Application/Control No.

10/781,729

Examiner

David Dunn

Applicant(s)/Patent under  
Reexamination

FUKAWATASE ET AL.

Art Unit

3616

**SEARCHED**

Class	Subclass	Date	Examiner
280	751 752 753	3/2/2006	DD
188	300	9/8/06	DD
updated above		↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference text		9/8/06	DD
search; see			
enclosed			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search; see enclosed.	3/2/2006	DD